

SLF60R065E7 / SLH60R065E7

600V N-Channel Multi-EPI Super-JMOSFET

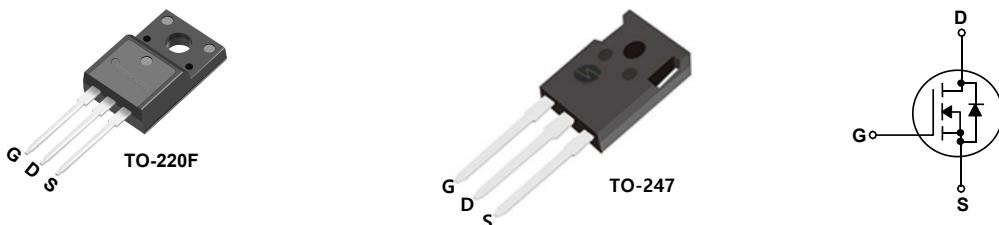
SLF60R065E7/SLH60R065E7

General Description

This Power MOSFET is produced using Maple semi's advanced Superjunction MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies.

Features

- 50A, 600V, $R_{DS(on)Typ} = 53\text{m}\Omega @ V_{GS} = 10\text{V}$
- Low gate charge(typ. $Q_g = 75\text{nC}$)
- High ruggedness Ultra
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings

$T_c = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	SLF60R065E7 / SLH60R065E7		Units
V_{DSS}	Drain-Source Voltage	600		V
I_D	Drain Current - Continuous ($T_c = 25^\circ\text{C}$)	50*		A
	- Continuous ($T_c = 100^\circ\text{C}$)	27.2*		A
I_{DM}	Drain Current - Pulsed	(Note 1)	129 *	A
V_{GSS}	Gate-Source Voltage		± 30	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	281	mJ
I_{AR}	Avalanche Current	(Note 1)	6.6	A
E _{AR}	Repetitive Avalanche Energy	(Note 1)	3.29	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	20	V/ns
	MOSFET dv/dt		100	
P_D	Power Dissipation ($T_c = 25^\circ\text{C}$)	48	329	W
	- Derate above 25°C	0.38	2.63	$\text{W}/^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		260	$^\circ\text{C}$

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	SLF60R065E7 / SLH60R065E7		Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	2.6	0.38	$^\circ\text{C}/\text{W}$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.		-	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	40	$^\circ\text{C}/\text{W}$

Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLF60R065E7	SLF60R065E7	T0-220F	Tube	1000	5000
SLH60R065E7	SLH60R090E7	T0-247	Tube	450	2250

Electrical Characteristics

$T_c = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_{\text{D}} = 250\mu\text{A}$	600	--	--	V
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_{\text{D}} = 250\mu\text{A}, T_j = 150^\circ\text{C}$	650	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 600 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1	μA
		$V_{\text{DS}} = 480 \text{ V}, T_c = 125^\circ\text{C}$	--	2.1	--	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA

On Characteristics

$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 250\mu\text{A}$	2.5	--	4.5	V
$R_{\text{DS}(\text{on})}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_{\text{D}} = 25\text{A}$	--	53	70	$\text{m}\Omega$

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{\text{DS}} = 400 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1\text{MHz}$	--	3208	--	pF
C_{oss}	Output Capacitance		--	81	--	pF
C_{rss}	Reverse Transfer Capacitance		--	--	--	pF

Switching Characteristics

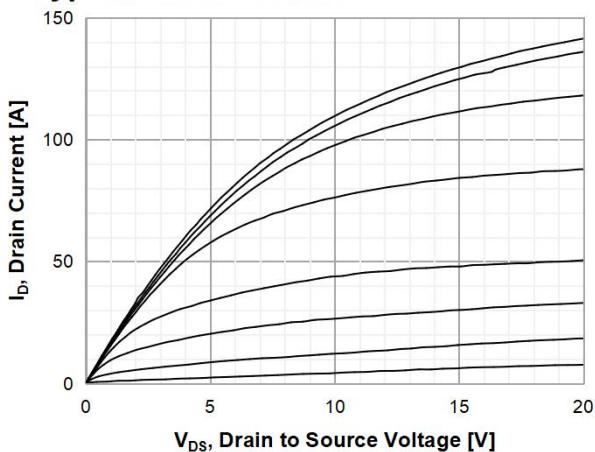
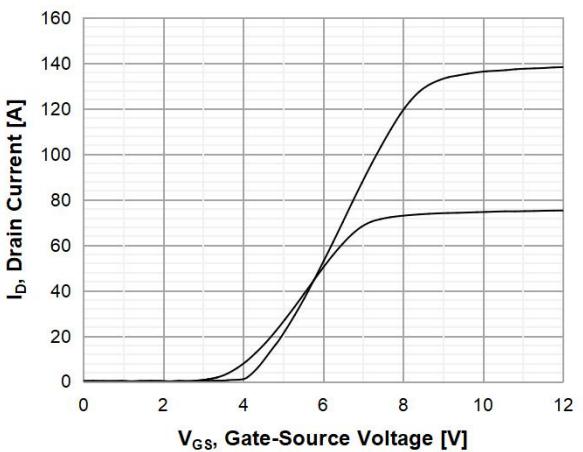
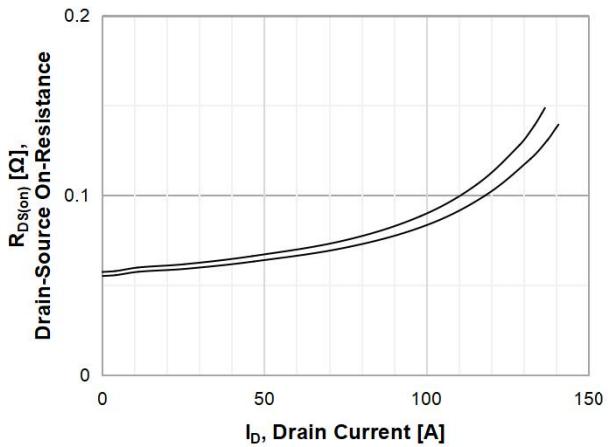
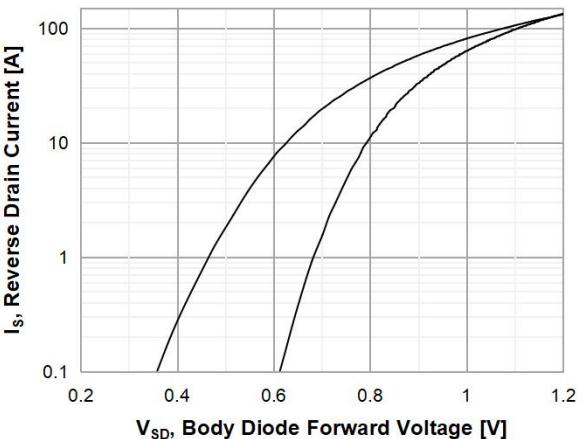
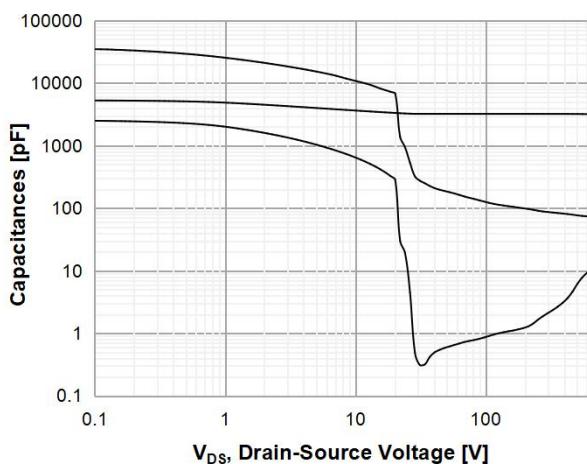
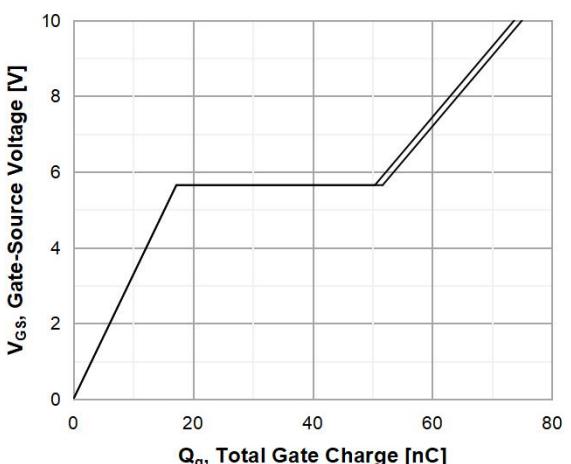
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DS}} = 400 \text{ V}, I_{\text{D}} = 25\text{A}, R_{\text{G}} = 10 \Omega, V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5)	--	17	--	ns
t_r	Turn-On Rise Time		--	8	--	ns
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time		--	71	--	ns
t_f	Turn-Off Fall Time		--	9	--	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 400 \text{ V}, I_{\text{D}} = 25 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5)	--	75	--	nC
Q_{gs}	Gate-Source Charge		--	17.2	--	nC
Q_{gd}	Gate-Drain Charge		--	34.5	--	nC
R_{G}	Gate Resistance	$f = 1\text{MHz}$		1.3		Ω

Drain-Source Diode Characteristics and Maximum Ratings

I_s	Maximum Continuous Drain-Source Diode Forward Current	--	--	50	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	129	A
V_{SD}	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_s = 25\text{A}$	--	--	1.2
t_{rr}	Reverse Recovery Time	$V_{\text{DD}} = 400 \text{ V}, I_s = 25\text{A}, dI_F / dt = 100 \text{ A/us}$ (Note 4)	--	413	--
Q_{rr}	Reverse Recovery Charge		--	7.2	--

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $I_{\text{AS}} = 6.6\text{A}, V_{\text{DD}} = 50\text{V}, R_{\text{G}} = 25\Omega, \text{Starting } T_j = 25^\circ\text{C}$
3. $I_{\text{SD}} \leq 21.5\text{A}, di/dt \leq 100\text{A/us}, V_{\text{DD}} \leq 400\text{V}, \text{Starting } T_j = 25^\circ\text{C}$
4. Pulse Test : Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
5. Essentially independent of operating temperature

Typical Characteristics**Figure 1. On-Region Characteristics****Figure 2. Transfer Characteristics****Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage****Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature****Figure 5. Capacitance Characteristics****Figure 6. Gate Charge Characteristics**

Typical Characteristics (Continued)

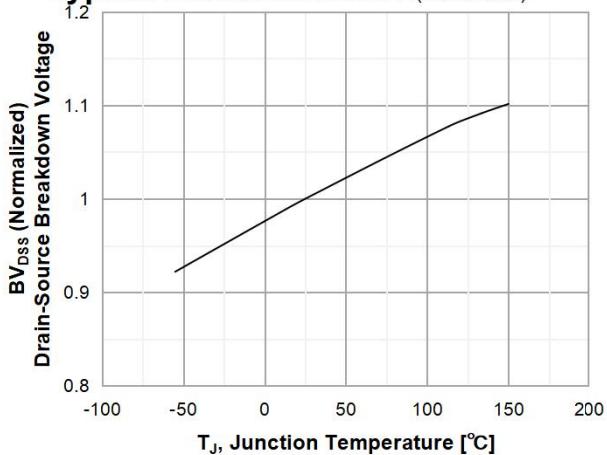


Figure 7. Breakdown Voltage Variation
vs Temperature

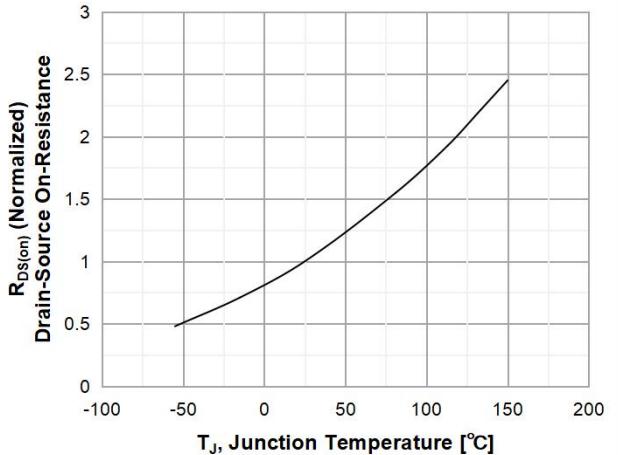


Figure 8. On-Resistance Variation
vs Temperature

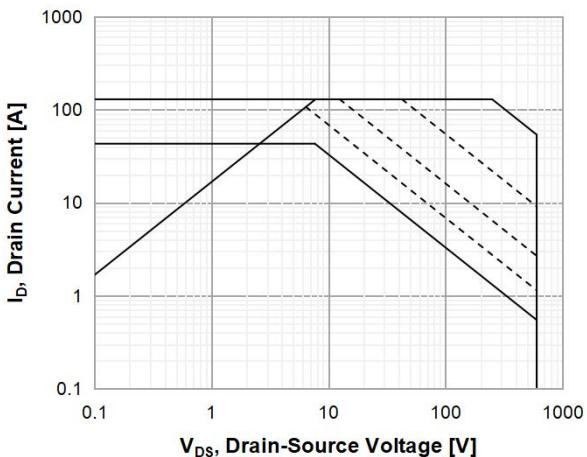


Figure 9. Maximum Safe Operating Area

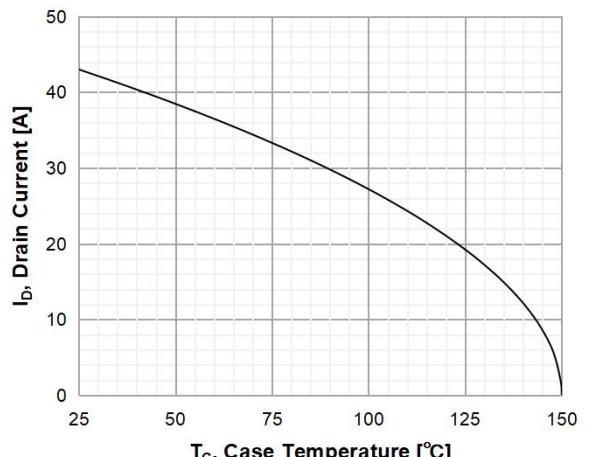


Figure 10. Maximum Drain Current vs.
Case Temperature

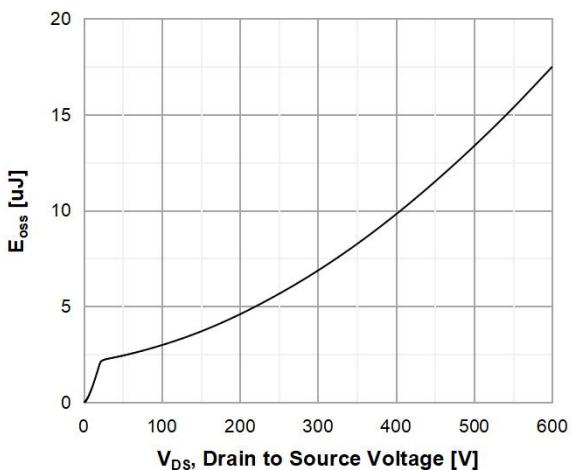


Figure 11. E_{oss} vs. Drain to Source Voltage

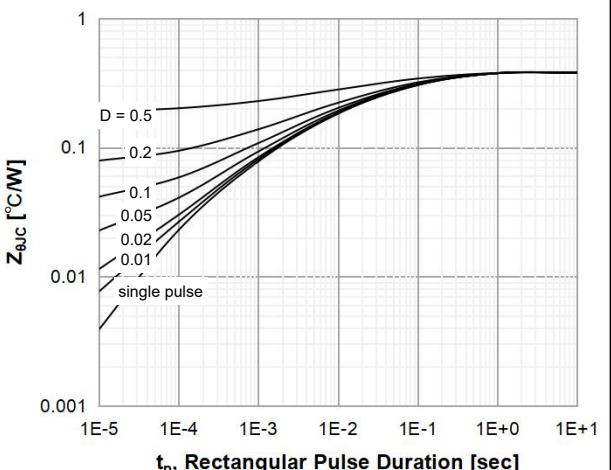
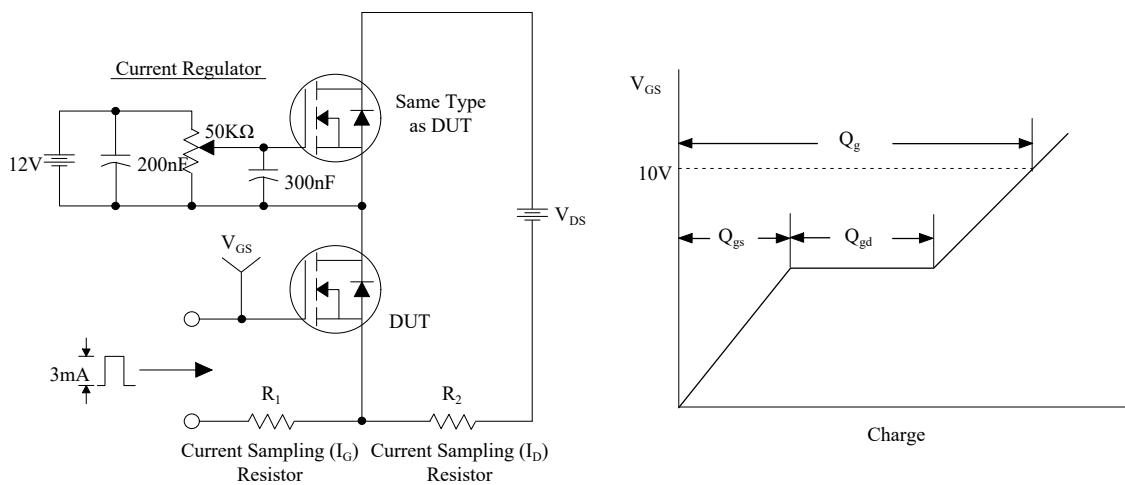
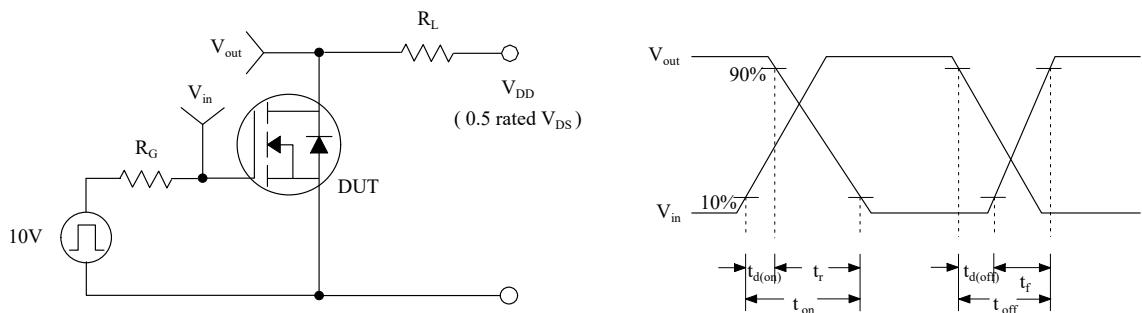


Figure 12. Transient Thermal Response Curve

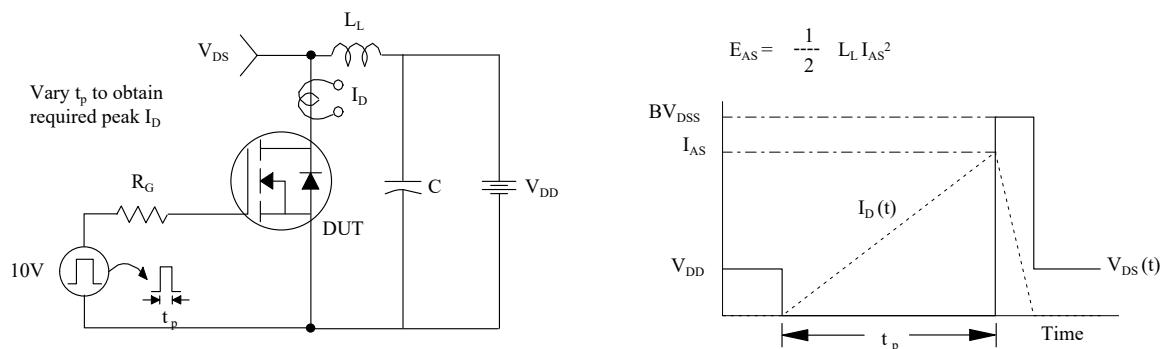
Gate Charge Test Circuit & Waveform



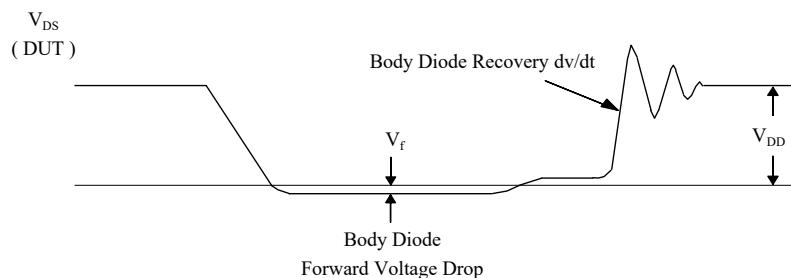
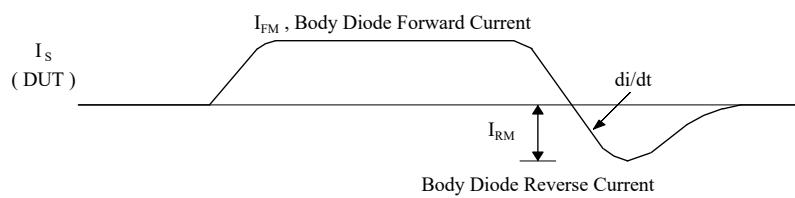
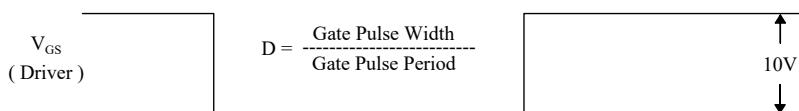
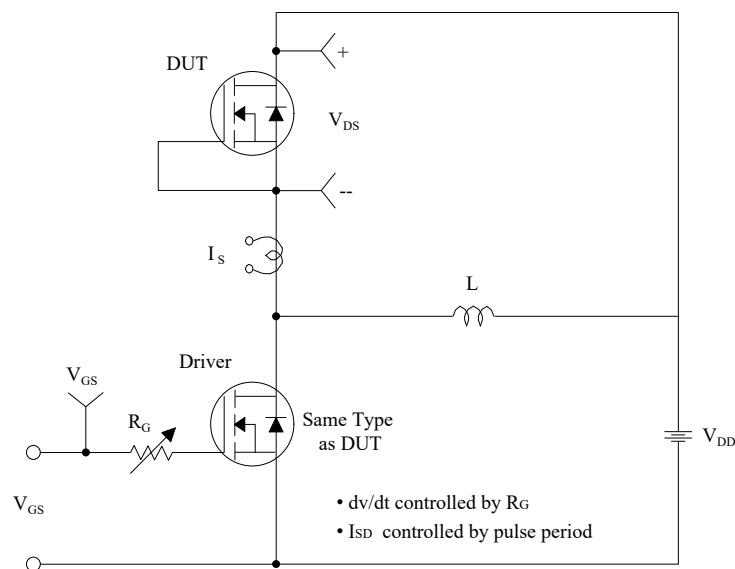
Resistive Switching Test Circuit & Waveforms



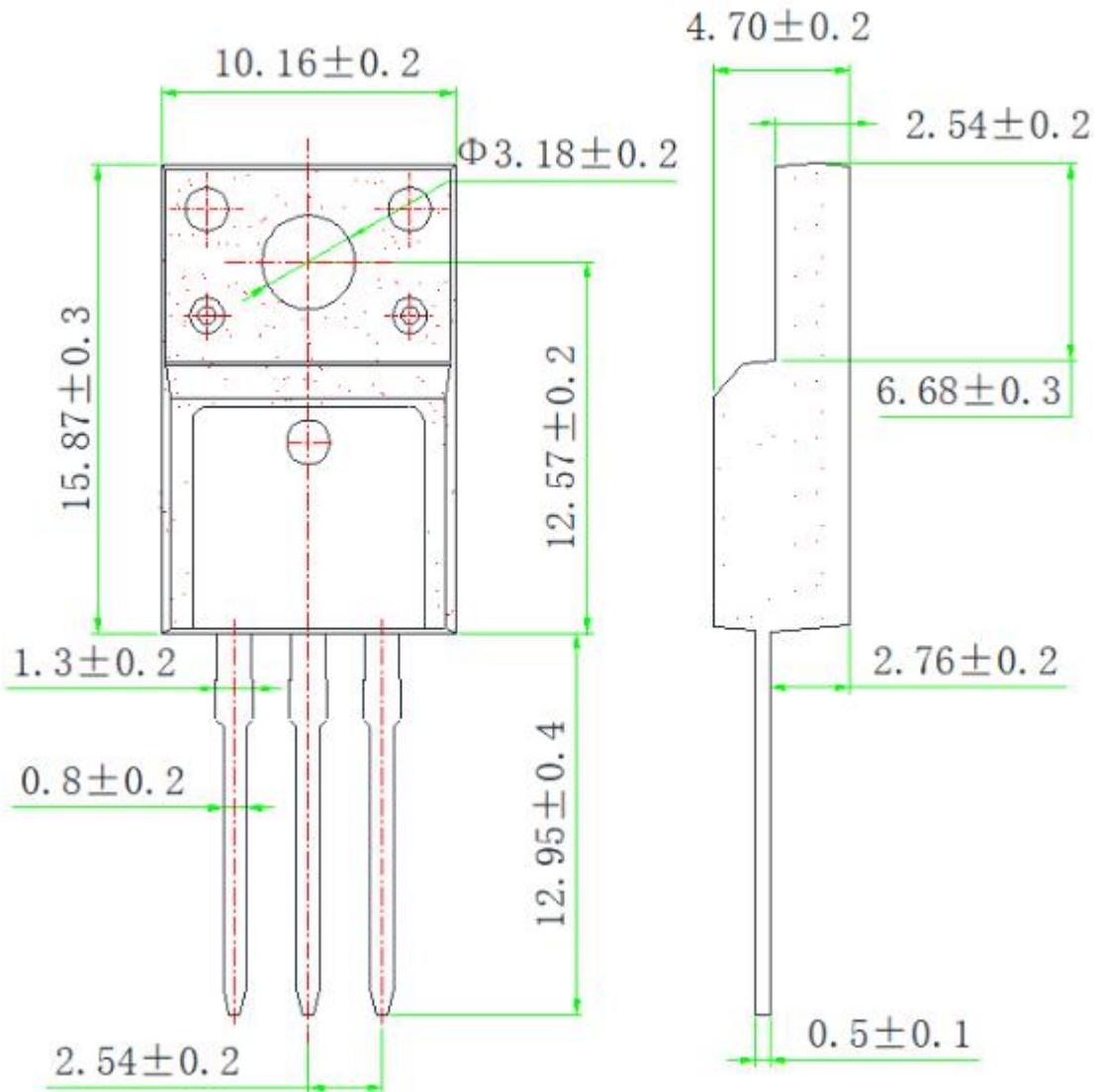
Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms



TO-220F OUTLINE

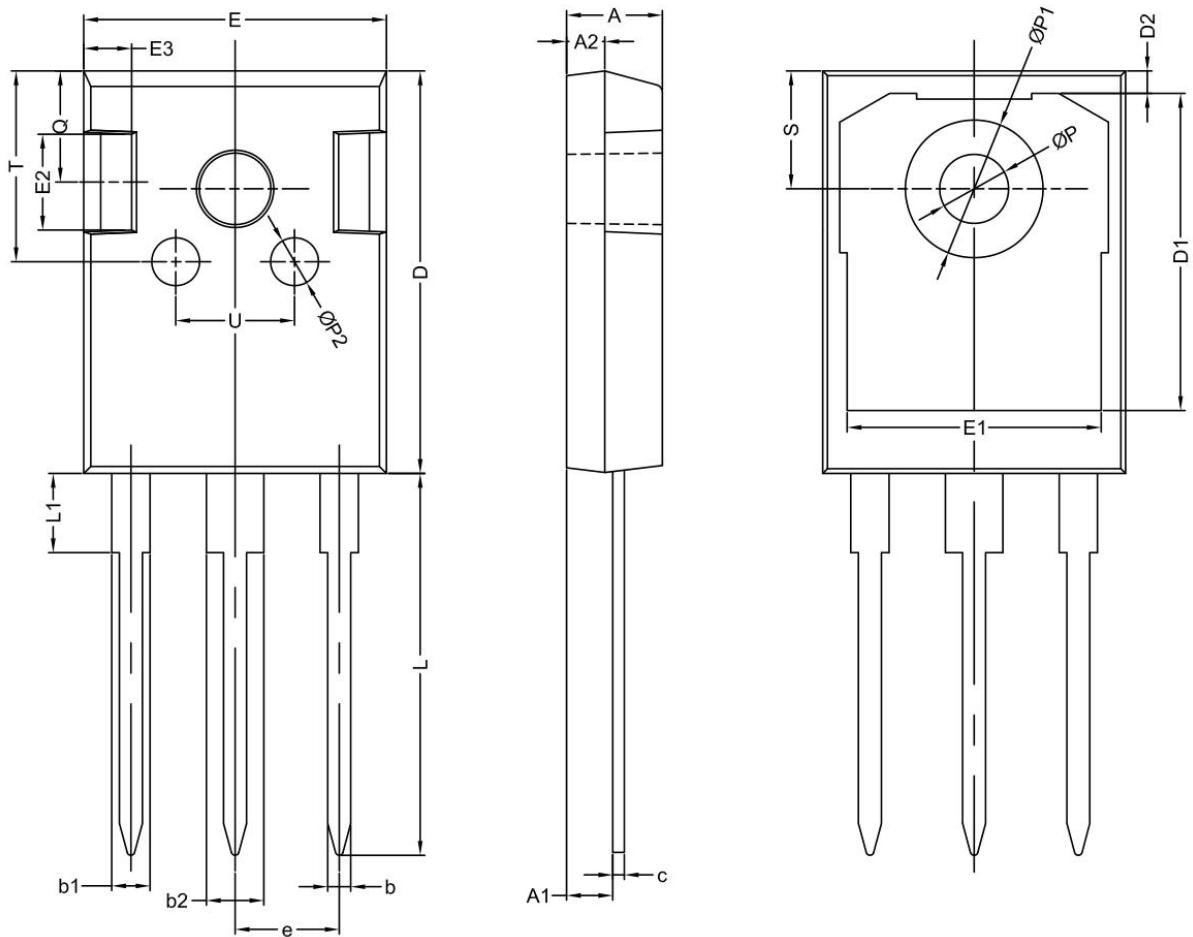


NOTE:

1.The plastic package is not marked as smooth surfaceRa =0.1;Subglossy surfaceRa=0.8

2.Undeclared tolerance ± 0.25 ,Unmarked filletRmax=0.25

TO-247 OUTLINE



SYMBOL	Mechanical Dimensions/mm			SYMBOL	Mechanical Dimensions/mm			SYMBOL	Mechanical Dimensions/mm		
	MIN	NOM	MAX						MIN	NOM	MAX
A	4.80	5.00	5.20	D	20.80	21.00	21.20	L1	-	4.13	-
A1	2.21	2.41	2.61	D1	-	16.55	-	Ø P	3.5	3.6	3.7
A2	1.90	2.00	2.10	E	15.60	15.80	16.0	Ø P1	-	-	7.40
b	1.10	1.20	1.35	E1		13.3		Ø P2	-	2.50	-
b1	-	2.00	-	E2		5.0		Q	-	5.8	-
b2	-	3.00	-	e	5.44			S	6.05	6.15	6.25
c	0.55	0.60	0.75	L	19.42	19.92	20.42	T	-	10.0	-

NOTE:

1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8

2.Undeclared tolerance ± 0.25 , Unmarked filletRmax=0.25